

Notice of References Cited	Application/Control No. 10/055,694	Applicant(s)/Patent Under Reexamination TERAGUCHI ET AL.	
	Examiner DEBBIE M LE	Art Unit 2167	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,789,088 B1	09-2004	Lee et al.	707/100
*	B	US-5,995,095 A	11-1999	Ratakonda, Krishna	715/500.1
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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